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IRF540, IRF541, IRF542, FAX: (973) 376-8960 IRF543, RF1S540, RF1S540SM

25A and 28A, 80V and 100V, 0.077 and 0.100 Ohm, N-Channel Power MOSFETs

Features

- · 25A and 28A, 80V and 100V
- $r_{DS(ON)} = 0.077\Omega$ and 0.100Ω
- Single Pulse Avalanche Energy Rated
- · Nanosecond Switching Speeds
- · Linear Transfer Characteristics
- High Input Impedance
- · Related Literature

Components to PC Boards"

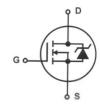
Ordering Information

PART NUMBER	PACKAGE	BRAND
IRF540	TO-220AB	IRF540
IRF541	TO-220AB	IRF541
IRF542	TO-220AB	IRF542
IRF543	TO-220AB	IRF543
RF1S540	TO-262AA	RF1S540
RF1S540SM	TO-263AB	RF1S540SM

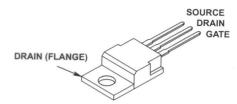
Description

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

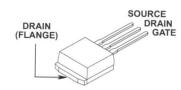
Symbol



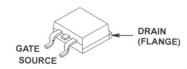
JEDEC TO-220AB



JEDEC TO-262AA



JEDEC TO-263AB



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Absolute Maximum Ratings T_C = 25°C, Unless Otherwise Specified

	IRF540, RF1S540,				
	RF1S540SM	IRF541	IRF542	IRF543	UNITS
Drain to Source Breakdown Voltage (Note 1)V _{DS}	100	80	100	80	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1) V_{DGR}	100	80	100	80	V
Continuous Drain Current	28	28	25	25	Α
T _C = 100°CI _D	20	20	17	17	Α
Pulsed Drain Current (Note 3)	110	110	100	100	Α
Gate to Source Voltage	±20	±20	±20	±20	V
Maximum Power Dissipation	150	150	150	150	W
Dissipation Derating Factor	1	1	1	1	W/oC
Single Pulse Avalanche Energy Rating (Note 4) EAS	230	230	230	230	mJ
Operating and Storage Temperature T _J , T _{STG}	-55 to 175	-55 to 175	-55 to 175	-55 to 175	°C
Maximum Temperature for Soldering		200	200	200	°C
Leads at 0.063in (1.6mm) from Case for 10s T _L		300	300	300	°C
Package Body for 10s, See Techbrief 334 T _{pkg}	260	260	260	260	-C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE

1. $T_J = 25^{\circ}C$ to $T_J = 150^{\circ}C$.

Electrical Specifications T_C = 25°C, Unless Otherwise Specified

PARAMETER	PARAMETER SYMBOL TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRF540, IRF542, RF1S540, RF1S540SM	BV _{DSS}	$I_D = 250 \mu A$, $V_{GS} = 0V$ (Figure 10)	100	-	-	V
IRF541, IRF543	1		80	-	-	V
Gate to Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	2	-1	4	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V	-	-	25	μА
		V_{DS} = 0.8 x Rated BV _{DSS} , V_{GS} = 0V T_J = 150°C	-	-	250	μА
On-State Drain Current (Note 2) IRF540, IRF541, RF1S540, RF1S540SM	I _{D(ON)}	V _{DS} > I _{D(ON)} × r _{DS(ON)} MAX, V _{GS} = 10V (Figure 7)	28	-	,	А
IRF542, IRF543	1		25	-	-	А
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±20V		-	±100	nA
Drain to Source On Resistance (Note 2) IRF540, IRF541, RF1S540, RF1S540SM	r _{DS(ON)}	I _D = 17A, V _{GS} = 10V (Figures 8, 9)		0.060	0.077	Ω
IRF542, IRF543	7			0.080	0.100	Ω
Forward Transconductance (Note 2)	9fs	V _{DS} ≥ 50V, I _D = 17A (Figure 12)	8.7	13	-	S
Turn-On Delay Time	t _{d(ON)}	$\begin{array}{l} V_{DD} = 50 V_{,} \ I_{D} \approx 28 A, \ R_{G} \approx 9.1 \Omega, \ R_{L} = 1.7 \Omega \\ (\text{Figures 17, 18) MOSFET Switching Times are} \\ \text{Essentially Independent of Operating} \\ \text{Temperature} \end{array}$		15	23	ns
Rise Time	t _r			70	110	ns
Turn-Off Delay Time	t _{d(OFF)}			40	60	ns
Fall Time	t _f			50	75	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	V_{GS} = 10V, I_D = 28A, V_{DS} = 0.8 x Rated BV _{DSS} , $I_{g(REF)}$ = 1.5mA (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature		38	59	nC
Gate to Source Charge	Qgs			8	-	nC
Gate to Drain "Miller" Charge	Q _{gd}			21	-	nC

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS			TYP	MAX	UNITS
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz		-	1450	-	pF
Output Capacitance	Coss	(Figure 11)			550	-	pF
Reverse Transfer Capacitance	C _{RSS}				100		pF
Internal Drain Inductance LD Measured From the Contact Screw on Tab To Center of Die Measured From the Drain Lead, 6mm (0.25in) from Package to Center of Die Measured From the Drain Lead, 6mm (0.25in) from Package to Center of Die	L _D	Contact Screw on Tab	Symbol Showing the	-	3.5	-	nН
	-	4.5	-	nH			
Internal Source Inductance	L _S	Measured From the Source Lead, 6mm (0.25in) From Header to Source Bonding Pad	Go EL _S	-	7.5	-	nH
Thermal Resistance Junction to Case	$R_{\theta JC}$			-	-	1	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Free Air Operation		-	-	80	°C/W
	$R_{\theta JA}$	RF1S540SM Mounted on FR-4 Board with Minimum Mounting Pad		-	-	62	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I _{SD}	Modified MOSFET Sym-	♦ D	1-1	-	28	А
Pulse Source to Drain Current (Note 3)	ISDM	bol Showing the Integral Reverse P-N Junction Diode	G S	-	-	110	А
Source to Drain Diode Voltage (Note 2)	V _{SD}	$T_J = 25^{\circ}C$, $I_{SD} = 27A$, $V_{GS} = 0V$ (Figure 13)		-	-	2.5	V
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C$, $I_{SD} = 28A$, $dI_{SD}/dt = 100A/\mu s$		70	150	300	ns
Reverse Recovery Charge	Q _{RR}	$T_J = 25^{o}C$, $I_{SD} = 28A$, $dI_{SD}/dt = 100A/\mu s$		0.44	1.0	1.9	μС

NOTES:

- 2. Pulse test: pulse width $\leq 300 \mu s$, duty cycle $\leq 2\%$.
- 3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4. V_{DD} = 25V, starting T_J = 25°C, L = 440 μ H, R_G = 25 Ω , peak I_{AS} = 28A. (Figures 15, 16).

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